Let's consider the deposition of Cu^{2+} from the solution of $CuCl_2$ and HCl. Let's define:

$$[CuCl_2] = c_{13}^b$$
 and $[HCl] = c_{23}^b$.

Hence: $[Cu^{2+}] = c_1$, $[H^+] = c_2$ and $[Cl^-] = c_3$. When $c_{13}^b \ll c_{23}^b$, Cu^{2+} is a trace ion and the limiting current density is given as [1]

$$I_{L0} = -\frac{2FD_1c_1^b}{\delta}$$
(1)

where δ is the thickness of the diffusion boundary layer. When only species 1 is reactive at the electrode the Nernst-Planck equations are (1D case) [1]:

$$j_1 = \frac{I}{z_1 F} = -D_1 \left(\frac{dc_1}{dx} + z_1 f c_1 \frac{d\phi}{dx} \right)$$
(2)

$$j_{k} = 0 = -D_{k} \left(\frac{dc_{k}}{dx} + z_{k} f c_{k} \frac{d\phi}{dx} \right) \quad ; \quad k \neq 1$$
(3)

where f = F/RT. From eq. (3), the concentration profile can be integrated as

$$c_{k}(x) = c_{k}^{b} e^{z_{k} f[\phi^{b} - \phi(x)]} \implies c_{k}(x) = c_{k}^{b} e^{z_{k} f \Delta \phi} \quad ; \quad k \neq 1$$

$$\tag{4}$$

where $\Delta \phi$ is the potential drop in the diffusion boundary layer. It can be show [1] that the current density is given as:

$$\frac{I}{z_1 F} = \frac{D_1}{\delta} \sum_{k \neq 1} \left(1 - \frac{z_k}{z_1} \right) c_k^b \left(e^{z_k f \Delta \phi} - 1 \right)$$
(5)

Applying the above equation to our case, it is obtained that

$$\frac{I}{2F} = \frac{D_1}{\delta} \left[\frac{1}{2} c_2^b \left(e^{f\Delta\phi} - 1 \right) + \frac{3}{2} c_3^b \left(e^{-f\Delta\phi} - 1 \right) \right]$$
(6)

At the limiting current $c_1(0) = 0$, which means via electroneutrality that $c_2(0) = c_3(0)$. Using eq. (4):

$$c_2^b e^{f\phi_L} = c_3^b e^{-f\phi_L} \quad \Leftrightarrow \quad e^{f\phi_L} = \sqrt{\frac{c_3^b}{c_2^b}} \tag{7}$$

Inserting this to eq. (6), the limiting current density is given as

$$\frac{I_{L}}{2F} = \frac{D_{1}}{2\delta} \left[c_{2}^{b} \left(\sqrt{\frac{c_{3}^{b}}{c_{2}^{b}}} - 1 \right) + 3c_{3}^{b} \left(\sqrt{\frac{c_{2}^{b}}{c_{3}^{b}}} - 1 \right) \right] = \frac{D_{1}}{2\delta} \left[\left(\sqrt{c_{2}^{b}c_{3}^{b}} - c_{2}^{b} \right) + 3\left(\sqrt{c_{2}^{b}c_{3}^{b}} - c_{3}^{b} \right) \right] \\ = \frac{D_{1}}{2\delta} \left[4\sqrt{c_{2}^{b}c_{3}^{b}} - c_{2}^{b} - 3c_{3}^{b} \right] = \frac{D_{1}}{2\delta} \left[4\sqrt{c_{23}^{b} \left(2c_{13}^{b} + c_{23}^{b} \right)} - 4c_{23}^{b} - 6c_{13}^{b} \right]$$
(6)

because $c_2^b = c_{23}^b$ and $c_3^b = 2c_{13}^b + c_{23}^b$. Modifying further:

$$I_{L} = \frac{4FD_{1}c_{13}^{b}}{\delta} \left[\sqrt{\frac{1}{r} \left(2 + \frac{1}{r} \right)} - \frac{1}{r} - \frac{3}{2} \right] \quad ; \quad r = \frac{c_{13}^{b}}{c_{23}^{b}} \tag{7}$$

In the limiting case $r \rightarrow \infty$ the system is binary (only CuCl₂) the limiting current density is

$$I_{L} = -\frac{6FD_{1}c_{13}^{b}}{\delta} = 3I_{L0}$$
(8)

For the trace case, eq. (6) is better to write as follows:

$$I_{L} = \frac{4FD_{1}c_{23}^{b}}{\delta} \left[\sqrt{2r+1} - 1 - \frac{3}{2}r \right]$$
(9)

When $r \rightarrow 0$, $\sqrt{2r+1} \rightarrow 1+r$ which then recovers eq. (1) as expected. For computer simulations, the following form is useful

$$\frac{I}{I_{L0}} = -\left[\frac{1}{2r}\left(e^{f\Delta\phi} - 1\right) + 3\left(1 + \frac{1}{2r}\right)\left(e^{-f\Delta\phi} - 1\right)\right]$$
(10)

The surface concentration of H⁺ and Cl⁻ can be calculated from eq. (4) and that of Cu²⁺ from the electroneutrality condition $2c_1 + c_2 = c_3$. The electrode potential can then be calculated from the Nernst equation as

$$E = E^{0'} + \frac{RT}{2F} \ln\left(\frac{c_1(0)}{c^*}\right)$$
(11)

where c^* is the standard concentration 1.0 M. The total potential is $E - \Delta \phi$ because we defined $\Delta \phi$ as $\phi^b - \phi(0)$ but the electrode potential is defined $\phi_{\text{electrode}} - \phi_{\text{solution}}$. Hence, giving values for $\phi < \phi_L$ the full current-voltage can be simulated.



Left: Potential drop in the diffusion double layer; r = 100 (green), 10 (cyan), 1 (yellow), 0.1 (orange), 0.01 (blue). Right: Current-voltage curves; color code the same.

[1] K. Kontturi, L. Murtomäki, J.A. Manzanares, Ionic Transport Processes, Oxford University Press, 2008, pp. 85-87.